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Linear and Nonlinear Spectroscopy With the Tunable AC Scanning Tunneling Microscope

by

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#### 12. ABSTRACT (Maximum 200 words)

The tunable microwave frequency AC scanning tunneling microscope (ACSTM) has opened the possibility of recording local spectra and local chemical information on insulator surfaces much as the conventional STM has done for metals and semiconductors. We describe the various types of spectroscopies that can be performed with the ACSTM. These include linear spectroscopies where the amplitude at the modulation frequency is measured as well as nonlinear spectroscopies utilizing the amplitudes of the harmonics of the modulation frequency generated in the tunneling junction. Spectroscopy in the microwave frequency range also enables heretofore unrealizable measurements on conducting substrates such as the rotational spectroscopy of a single adsorbed molecule.

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# LINEAR AND NONLINEAR SPECTROSCOPY WITH THE TUNABLE AC SCANNING TUNNELING MICROSCOPE

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### **Abstract**

The tunable microwave frequency AC scanning tunneling microscope (ACSTM) has opened the possibility of recording local spectra and local chemical information on insulator surfaces much as the conventional STM has done for metals and semiconductors. We describe the various types of spectroscopies that can be performed with the ACSTM. These include linear spectroscopies where the amplitude at the modulation frequency is measured as well as nonlinear spectroscopies utilizing the amplitudes of the harmonics of the modulation frequency generated in the tunneling junction. Spectroscopy in the microwave frequency range also enables heretofore unrealizable measurements on conducting substrates such as the rotational spectroscopy of a single adsorbed molecule.

#### 1. Introduction

The scanning tunneling microscope (STM) has enabled a host of measurements of local chemical environment on metal and semiconductor surfaces [1-3]. Related techniques have spring up which have allowed imaging of insulator surfaces [4,5]. Recent advances in near-field microscopies have enabled the spectra and dynamics of single molecules on surfaces to be recorded under special circumstances, but the imaging resolution remains in the 10 nm range under optimal conditions [6-9].

A number of AC scanning tunneling microscopes have now been put together since Kochanski's initial invention of the technique [10–15]. The exciting possibility of these instruments is that one may combine the consistent atomic resolution of the STM with spectroscopic capabilities on surfaces with arbitrary electronic properties including insulators [16,17]. As described in this paper, a variety of spectroscopic measurements can be performed with these instruments.

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## 2. Experimental

The experiments described here were conducted in specially designed scanning tunneling microscopes equipped to handle microwave frequency signals up to 20 GHz. These various ACSTMs have been described previously [13–15]. We have operated ACSTMs both under ambient conditions and in ultrahigh vacuum (UHV) [13–15]. Importantly, for

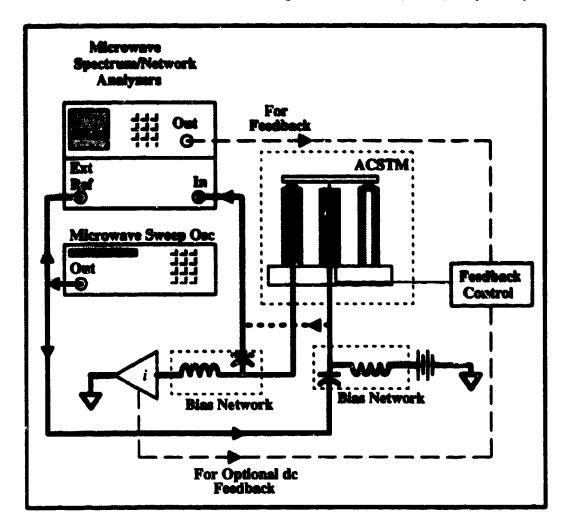


Figure 1. Schematic of the tunable ACSTM signal and control electronics. A microwave sweep oscillator supplies the ACSTM tip with the microwave frequency AC bias. Using a bias network a DC offset can also be applied. The reflected and/or transmitted microwaves are measured using network or spectrum analyzers. Feedback control of the probe tip can be accomplished using the DC current as in conventional STM or using the AC signal at the modulation frequency or one of its harmonics.

understanding the spectroscopy of adsorbates on surfaces, we can operate the UHV ACSTMs at temperatures as low as 4K [15]. We briefly review the critical components of our tunable ACSTMs. We also discuss a recent advance which has resulted in a lower and flatter background for spectroscopic measurements with the ACSTM [18].

A schematic of the instrument and detection scheme is shown in Figure 1 above. A narrow band microwave frequency oscillator is used to supply the microwave frequency modulation to the ACSTM probe tip. The oscillator has a bandwidth of 1 Hz and is tunable over the range 10 MHz-20 Ghz [19]. For sufficiently conducting samples, we use a bias network to supply a dc bias to the ACSTM probe tip along with the microwave frequency modulation and to separate the microwave and low frequency components of the tunneling current [20]. In this way, conventional STM can be used to provide feedback on metal and semiconductor surfaces while microwave signals are simultaneously collected. The small microwave signals are measured using extremely sensitive microwave test equipment [21]. For sufficiently thin insulators, we can record the microwaves transmitted to a conducting backplane. Similarly, we can measure microwave transmission for semiconductors and metals as well. A more general technique particularly useful for studying bulk insulators is to measure the microwaves reflected back down the ACSTM probe tip using a directional coupler or circulator. The signal—to—noise in reflection mode is substantially lower than in transmission mode where both are possible.

The ACSTM head is shown schematically in Figure 2. A beetle-style sample approach is used in all our current instruments [14,15,22]. A microwave frequency coaxial cable is fed through the center (scanner piezoelectric translator tube) [14]. A custom transition is used inside a shielded hypodermic tube within this piezoelectric tube to minimize microwave reflections from within our cabling [18]. For transmission measurements, a second connection is made to another coaxial microwave transmission line through one of the outer walker piezoelectric tubes as indicated in the figure.

Recently, we have found that we can lower and flatten the spectral background of our ACSTM spectra by placing the sample and probe tip in a cavity which is too small to support any resonances within the frequency range of the instrument, 0-22 GHz [18]. The beetle-style sample approach is maintained in this small cavity (diameter ~ 6 mm) by using a liquid metal seal to enclose the tunneling junction electrically [18]. A metal reservoir is attached to the center scanner piezoelectric tube and filled with liquid metal In/Ga/Sn eutectic. A metal insert in the sample holder dips into the liquid metal electrically enclosing the ACSTM tunneling junction. The dimensions of our present small cavity put the lowest supported resonance in the range of 100 GHz, well above any frequency measured in our experiments. This small cavity has the effect that stray reflections of the microwaves off the structures enclosing the ACSTM do not set up standing waves which would interfere with our spectroscopic measurements [18].

Michel and co-workers have come up with an alternate approach for measuring a series of harmonics generated in the ACSTM tunnel junction. They use what is essentially a fixed cavity instrument, but vary the modulation frequency such that the detected harmonic is always at the frequency of the cavity resonance [12,17]. This has the advantage that harmonics can be measured using the impedance match provided by the cavity. The disadvantage is that the harmonic generation can be a function of modulation frequency [16,17]. Nevertheless, with cleverly designed experiments and additional spectroscopic handles, the harmonic spectra obtained can be extremely useful as described below [17].

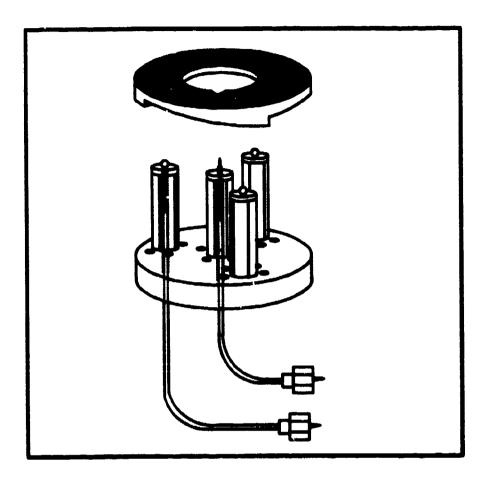


Figure 2. Schematic of the tunable ACSTM head. The microwave frequency bias is supplied by a microwave coaxial cable that runs up the center (scanner) piezoelectric tube. A custom microwave transition is built into a hypodermic tube inside the scanner piezo. Less than 500µ is left unshielded at the end of the probe tip. A beetle style sample approach is used in zir and in UHV. For bulk insulators, microwaves reflected back down the probe tip are measured. For conducting samples or thin insulators, transmitted and/or reflected microwaves are used. For transmission AC and for conventional STM measurements, a sample pick—up is used and runs through another of the piezoelectric (walker) tubes.

## 3. Imaging with the ACSTM

We have been able to achieve atomic resolution on graphite and WSe<sub>2</sub> with microwave frequency feedback mechanisms [16]. On insulating surfaces such as lead silicate glass we have achieved resolution of ca. 1 nm [16]. It may be that on crystalline insulators with well-defined stoichiometry, such as the alkali halides, atomic resolution may be routinely obtained, but this remains to be demonstrated. In this regard, the recently constructed UHV ACSTM described above should be of great importance in preparing and in characterizing samples with surface analytical tools prior to imaging.





Figure 3. Two images simultaneously recorded of a 1.5 $\mu$  x 1.5 $\mu$  region of WSe<sub>2</sub> surface with several multiatomic height steps due to partial exfoliation of the sample. The image on the left shows a constant current conventional STM topograph recorded with V<sub>tip</sub>=+2.0 V and I<sub>tunnel</sub>=100 pA. The simultaneously obtained image on the right shows the amp'itude at the third harmonic of the AC modulation frequency,  $f_o$ =2.440 GHz. Near the exfoliation of the WSe<sub>2</sub> the nonlinearity and thus the third harmonic signal are greatly enhanced. No special features appear in the conventional STM topography in these regions.

By simultaneous imaging in several modes — conventional constant current STM,  $f_0$  amplitude, and third harmonic amplitude, for example — we are able to compare features we can readily interpret in topography to the high frequency electronic properties of the surface. Such an experiment is shown in Figure 3. On the left, a conventional STM image shows a region of a WSe<sub>2</sub> surface where the top layers are partially exfoliated at the steps. The simultaneously recorded ACSTM third harmonic signal shows regions adjacent to the exfoliation with greatly enhanced third harmonic signal. We attribute this enhanced nonlinearity to the electronically discontinuous region of the sample. There is greater rectification in these ca. 100–200 nm wide regions due to a reduced carrier lifetime compared to the rest of the surface. Michel and co—workers have also adopted this strategy in order to measure doping densities and profiles in Si wafers under a thin oxide layer [17].

One important question to be addressed is the extent to which the microwaves pumped into the tunnel junction heat and/or perturb the adsorbates and surface in the vicinity of the tip. In order to assess the level of this perturbation, we have applied a microwave frequency modulation to the dc bias in conventional low temperature STM measurements of a temperature sensitive sample — benzene on Cu{111} at 77K [15]. A slight increase in temperature would greatly affect the mobility of the benzene molecules which remain fixed at and near steps at this temperature but remain mobile (as a two-dimensional gas) on the Cu{111} terraces [23]. Figure 4 shows a low temperature image of a Cu{111} surface where the benzene molecules adsorbed at the step edges appear unperturbed with microwaves applied to the ACSTM probe tip at 1 GHz. Thus in this case the junction, the sample, and the instrument do not appear to suffer from any deleterious heating effects. We have not seen evidence in any of our experiments for heating of the junction by the microwaves. We note that an additional measurement that can be made is to employ



Figure 4. A conventional STM image of benzene on Cu{111} at 77K in UHV. A microwave modulation at 1 GHz was simultaneously applied to the STM probe tip. The molecules in this regime are extremely sensitive to the substrate temperature. The residence times of the molecules at the various surface sites are not measurably altered with the application of the microwaves indicating that heating of the junction is negligible in this case.

Johnson noise thermometry using frequencies distinct from any supplied to or created (i.e. by harmonic generation) in the tunneling junction as in Ref. [24].

## 4. Spectroscopy with the ACSTM

## 4.1. LINEAR ACSTM SPECTROSCOPY

Amplitudes of the signal at f and at harmonics, nf, can be recorded at a particular position on the surface. This allows us a means to differentiate between the species on the surface, and will ultimately provide spectral handles to identify and to characterize surface species using the ACSTM [16]. The amplitude at f also determines the sensitivity of our instrument at the frequency used for imaging as described in Ref. [13]. We note that dielectric spectra can be assigned in terms of molecular rotations and other motions [16,25]. To this end, we have built a low temperature ultrahigh vacuum ACSTM to measure the rotational spectra of adsorbates in the ACSTM tunnel junction.

Microwave spectroscopy of small molecules in the gas phase has been used to yield structural information [26]. Condensed phase spectra have typically remained uninterpreted. Since molecules are known to perturb the electronic properties of the surrounding surface anisotropically [27], the rotating electronic perturbations of a rotating molecule can be measured at a single surface site as a modulated tunneling current. Since these rotational frequencies are in the microwave to far infrared frequency range, the frequencies at the lower end can be measured in principle with a low temperature ACSTM.

The rotational spectra of adsorbed H<sub>2</sub> molecules on Ag and Cu have previously been measured by electron energy loss spectroscopy [28,29]. Adsorbed PF<sub>3</sub> on a number of

metal surfaces is known from ESDIAD measurements to have a bound (hindered) to free rotor transition as the temperature is increased [30-32]. In NMR experiments, benzene has been shown to rotate on Pt particles which are predominantly textured Pt{111} [33,34]. STM images of azulene have been interpreted as rapidly rotating molecules [35]. We will use benzene molecules to illustrate how we will try to record a rotational spectrum using the ACSTM.

Benzene adsorbed on Pt{111} exhibits three different types of images depending upon adsorption site [27,36]. In the three-fold hollow adsorption sites on the surface, three depressions are seen in the STM images of the surrounding surface. This result is consistent with theoretical calculations of images of benzene and the known variety of binding sites for benzene on Pt{111} [36,37]. Figure 5 shows a schematic of the three lobe image of the benzene molecule and the surrounding surface.

By using conventional (DC) STM feedback and monitoring the AC components of the tunneling current, we expect to be able to measure the rotational frequencies of molecules and to distinguish between bound (frustrated) and free surface rotors. The proposed method for doing this is shown schematically in Figures 5 and 6. The electrons of the substrate, perturbed by the adsorbed molecules would easily follow the motion of the molecules as it rotates. At positions A and B (indicated in Figure 5) for a free rotor, the tunneling current would be modulated at three times the rotation frequency as the (three) apparent depressions of the LDOS are swept past the ACSTM tip by the rotating molecule. Thus the frequency composition at the two probe positions are the same. The frequency spectra are directly related to the rotation frequencies of the molecule. For a frustrated rotor, the molecule twists back and forth in the torsion mode potential well. Even with no excitation there is still zero point motion in this torsion. Once again, the charge follows torsional motion of the molecule. At position A the current is at a maximum when the molecule rotates the apparent depressions in the LDOS away from the probe and is a minimum when the molecule rotate the depressions under the probe tip. Thus the AC

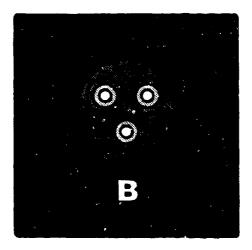


Figure 5. A schematic of a STM image of a benzene molecule in a three-fold hollow site as in Ref. [27] showing three lobes and three depressions in the LDOS of the surrounding substrate. A and B mark the ACSTM probe positions referenced in Figure 6.

component of the current appears at the torsion frequency at position A. Position B is the center of one of the apparent LDOS depression for the molecule's equilibrium location. Thus in each period, the molecule crosses through the equilibrium position twice. At the equilibrium position, the tunneling current is a minimum. At the maximum excursion from the equilibrium in each direction, the tunneling current is a twice the torsional frequency by the molecular motion. By noting whether the AC component of the tunneling current varies with position, free and frustrated rotors can then be differentiated. From the frequency spectra of the tunneling current, the rotational/torsional frequencies can be determined. As for gas phase molecules, these frequencies are sensitively dependent on the moments of inertia and thus the structure of the adsorbates. By matching this intramolecular structural information to the local chemical environment measured with the STM, we can probe the modification of intramolecular bonding due to the specific molecular adsorption site.

## 4.2. NONLINEAR ACSTM SPECTROSCOPY

We have previously discussed how the nonlinear or "harmonic spectra" can be used to glean information as to the local chemical environment by establishing the source(s) of the nonlinearities [16]. Briefly, the tunnel junction non-linearities which lead to harmonic generation are [10,16]:

- i) Coulomb blockade effects (where an electron which has just tunneled momentarily repels electrons which otherwise might have tunneled during the same half—cycle, but have insufficient energy) [38],
- ii) Local density of states which are not constant as a function of energy, and
- iii) Structural changes (dispersion effects) due to adsorbed or surface layers responding to the ac field.

By having a broadly tunable ACSTM, we are able to tune  $f_0$  and vary its amplitude, and by then also recording amplitudes at a several harmonics,  $n_0$ , we are able to differentiate between these effects. We can thus determine the charging thresholds (i), electronic structure (ii), and rates of motion (iii) of the species on the surface at the position of the ACSTM tip. The nonlinearities above are differentiated based upon their modulation frequency  $(f_0)$  and amplitude dependences as follows:

- i) Harmonic amplitudes depend on the modulation frequency and amplitude. High harmonic amplitudes simultaneously increase as the modulation amplitude surpasses the (voltage) threshold for tunneling a second electron at the peak of the modulation half—cycle for only a short time [38]. As  $f_o$  is reduced and charge can dissipate within a half—cycle, the threshold disappears and the harmonics are reduced.
- ii) Harmonic amplitudes are frequency independent, but do depend on modulation amplitude.
- iii) Frequency dependent absorptions and dissipation are characteristic of surface species.

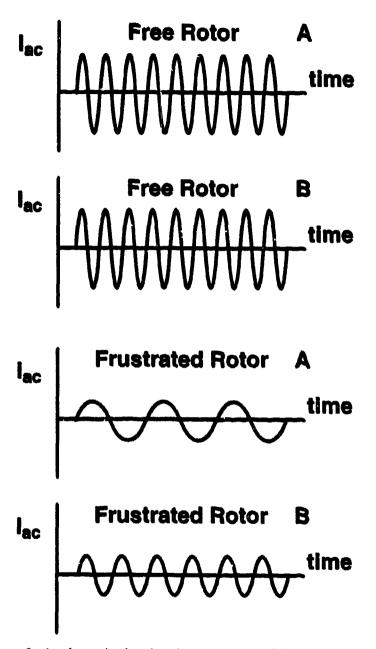


Figure 6. A schematic showing the expected ACSTM current for a free and frustrated rotor when measured at positions A and B shown in Figure 5. For a free rotor the signal is the same for both probe positions and for appears here at three times the rotation frequency. For a frustrated rotor, the signal depends on the probe position. At position A, away from the extremum change in LDOS, the signal appears predominantly at the frustrated rotation frequency. At position B, at the extremum change in LDOS, the signal appears predominantly at twice the frustrated rotation frequency.

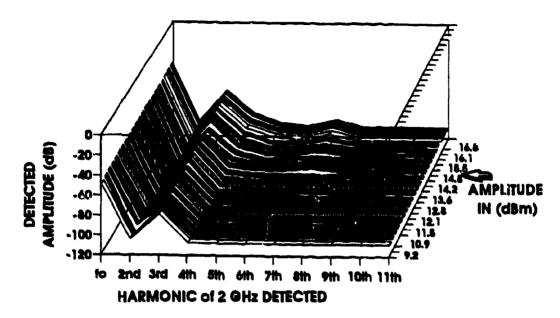


Figure 7. The harmonic amplitudes vary as the modulation amplitude at  $f_0=2$  GHz is changed, and increase sharply as an apparent threshold at 15 dBm (indicated by the arrow) is surpassed.

We previously showed that while probing the same position on a lead silicate glass surface the envelope of harmonics generated in the ACSTM tunneling did depend upon the modulation frequency (for  $f_0=2.0$  and 2.5 GHz) [16]. In Figure 7 we show the dependence of the harmonics generated on the amplitude of the modulation applied at  $f_0=2$  GHz. The threshold behavior observed is consistent with a charging effect (i). In order to confirm this assignment, we are attempting to measure the charge dissipation rate on the surface by lowering the modulation frequency as described above. We note that it is in only a fraction of the modulation periods that single electrons tunnel [10]. It is then in only a very small fraction of modulation periods in which more than one electron may tunnel; the nonlinearities are not large. It is because we can record over many cycles rapidly using these high modulation frequencies that we are able to measure the nonlinearities due to multiple electron tunneling.

These harmonic measurements enable the identification and study of the species in the tunnel junction in a manner analogous to electrochemical redox measurements and molecular spectroscopy. We now have the means to identify and to characterize the species at the position of the ACSTM tip, and the simultaneous ability to interrogate the chemical environment by imaging the surrounding surface.

## 5. Prospects

We have shown how the ACSTM can be used to record local chemical and dynamical information on the surfaces of a wide range of materials. This information obtained is complementary to that obtained from conventional STMs and AFMs. By studying well characterized insulator surfaces in UHV, we expect to develop a predictive understanding of the imaging and spectroscopic capabilities of the ACSTM.

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